

8755 W. Higgins Road Suite 500 Chicago, Illinois USA 60631

Nov 28th, 2024

RE: PCN # ESU270-98- New Wafer Foundry and Additional Backend Location Approval for SP1005-01ETG & SP1007-01ETG & SP1007-01ETG-1

To our valued customer,

Littelfuse would like to notify you that we are going to change wafer foundry location and add an additional backend location for SP1005-01ETG & SP1007-01ETG & SP1007-01ETG-1 TVS Diode Array (SPA® Diodes) products. The target foundry & backend sites are existing suppliers to Littelfuse, and the affected products are incremental to other Littelfuse products at the site. There are no changes to fit, form, and function of finished products.

The affected products will be fully qualified in accordance with established performance and reliability criteria. Samples would be provided upon your request.

Products Affected:

Affected Part Numbers
SP1005-01ETG
SP1007-01ETG
SP1007-01ETG-1

Form, fit, function changes: None Part number changes: None Effective date: Feb 28th, 2025 or sooner Replacement products: N/A Last time buy: N/A

This PCN is for your information and acknowledgement. If you have any other questions or concerns, please contact your local sales team or product team below for further assistance.

We value your business and look forward to assisting you whenever possible.

Best Regards,

Sophia Hu TVS Diode Array Assistant Product Manager Semiconductor Business Unit, Wuxi, China +86 510 85277701 - 7653 shu@littelfuse.com



800 E. Northwest Highway Des Plaines, IL 60016

Product/Process Change Notice (PCN)

		o ()				
PCN# :		Contact Information				
ESU270-98 Date: Nov 28th, 2024		Name : Sophia Hu				
Product Identification:		Title : Assistant Product Marketing Manager				
New Wafer Foundry and Additional Backend Location Approval for SP1005-01ETG & SP1007-01ETG &		Phone # : +86 13771377277				
		Fax# : N/A				
SP1007-01ETG-1		E-mail : shu@littelfuse.com				
Implementation Date for Change:						
Feb 28th, 2025 or sooner						
Category of Change:	Description of	f Change:				
Assembly Process	New Wafer Foundry and Additional Backend Location Approval for SI					
Data Sheet		1007-01ETG & SP1007-01ETG-1 SPA™ TVS Diode Arrays ere are no changes to fit, form, function of the finished product.				
Technology						
Discontinuance/Obsolescence						
Equipment						
Manufacturing Site						
🛛 Raw Material						
Testing						
Fabrication Process						
Other:						
Important Dates:						
Qualification Samples Available: Upon	n request	Last Time Buy:				
S Final Qualification Data Available: Upo	on request					
Date of Final Product Shipment:						
Method of Distinguishing Changed Produ	ct					
Product Mark,						
⊠ Date Code,						
Other, Littelfuse internal work order documentation						
Demonstrated or Anticipated Impact on F	orm, Fit, Func	ction or Reliability:				
N/A						
LF Qualification Plan/Results:						
Yes						
Customer Acknowledgement of Receipt: acknowledgement, you can	Littelfuse req	uests you acknowledge receipt of this PCN. In your				
grant approval or request additional information. Littelfuse will assume the change is acceptable if no acknowledgement i received within 30 days						
of this notice. Lack of any additional response within 90 days of PCN issuance further constitutes acceptance of the change.						



PCN Report ETR # Various	
Prepared By	: Wayne Wang- Sr.Product Engineer,
	Toby Chung -Product Engineer, Sophia Hu- Assistant Product Manager
Date	: 2024/11/19
Device	: Please refer to 2.1.
Revision	: A

1.0 Objective:

The purpose of this project is to qualify alternative wafer foundry and assembly for TVS Diode Array products. Following pages summarize the physical, electrical and reliability test performance in qualification lots.

2.0 Applicable Devices:

2.1 **Product name:**

Affected Part Numbers
SP1005-01ETG
SP1007-01ETG
SP1007-01ETG-1

3.0 Assembly, Process & Material Differences/Changes:

3.1 Assembly Changes:

No change of assemble method.

3.2 Process Changes:

No change of process method.

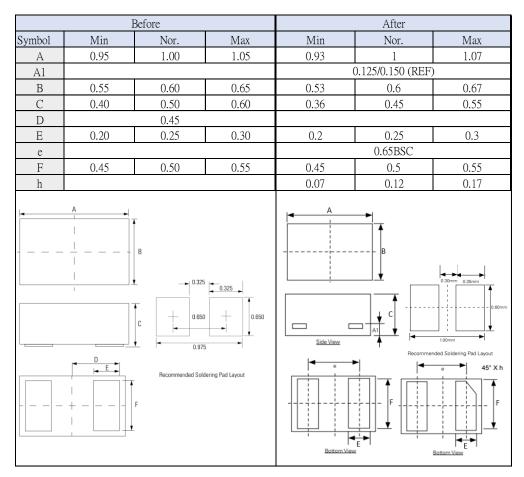
3.3 Material Change:

Wafer change

4.0 Packing Method

Category		Before	After
	Reel size	7"	7"
	Qty per reel	10000	10000
Reel	Reel per inner box	1	1
	Reel per outer box	30	30 & 20
	Reel color	Black	Black & Blue

5.0 Physical Differences/Changes:



6.0 Reliability Test Results Summary:

6.1 Reliability for alternative wafer foundry/ assembly

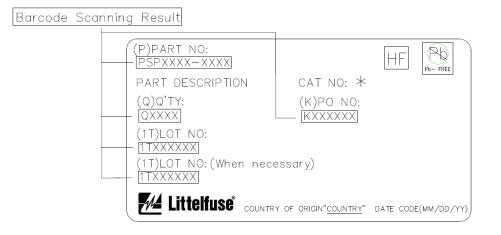
Test Items	Condition	S/S	Results	ETR #
Pre-conditioning (PC)	JESD22-A113	308 each lot	0/924	
DC Blocking (HTRB)	Bias = VRWM, Ta = 150°C, Duration = 1008 Hours	77 each lot	0/231	
Temperature Cycle (TC)	Ta = -55°C to 150°C, Duration = 1000 Cycles	77 each lot	0/231	
Temperature/Humidity (H3TRB)	Ta = 85°C, 85% RH, Bias = VRWM, Duration = 1008 Hours	77 each lot	0/231	TR24-11-012447
Unbiased HAST (UHAST)	Ta = 130°C, 85%RH, Duration = 96 Hours	77 each lot	0/231	
Resistance to Solder Heat (RSH)	260°C, 10 sec, M-2031	30each lot	0/90	
Moisture Sensitivity Level (MSL)	Per Jedec J-STD-020D Level 1	11 each lot	0/33	
Solderability (SD)	J-STD-002	22each lot	0/66	

7.0 Electrical Characteristic Summary:

Electrical performances were comparable and characterization data is available upon request.

8.0 Changed Part Identification:

Both suppliers were qualified by Littelfuse and product can be identified by CAT NO on the label.



9.0 Approvals:

Sophia Hu SPA Assistant Product Manager Littelfuse, Wuxi Wayne Wang Sr. SPA Product Engineer Littelfuse, Wuxi Emily Chen SPA Product Engineer Littelfuse, HsinChu